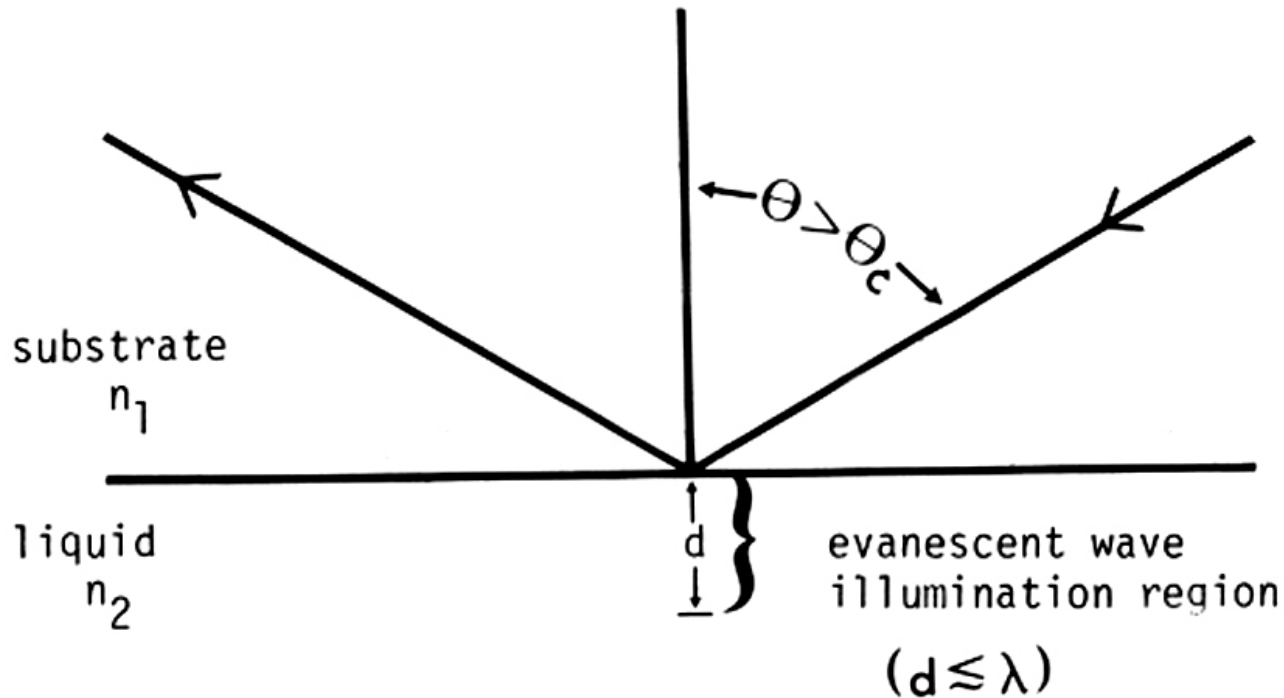
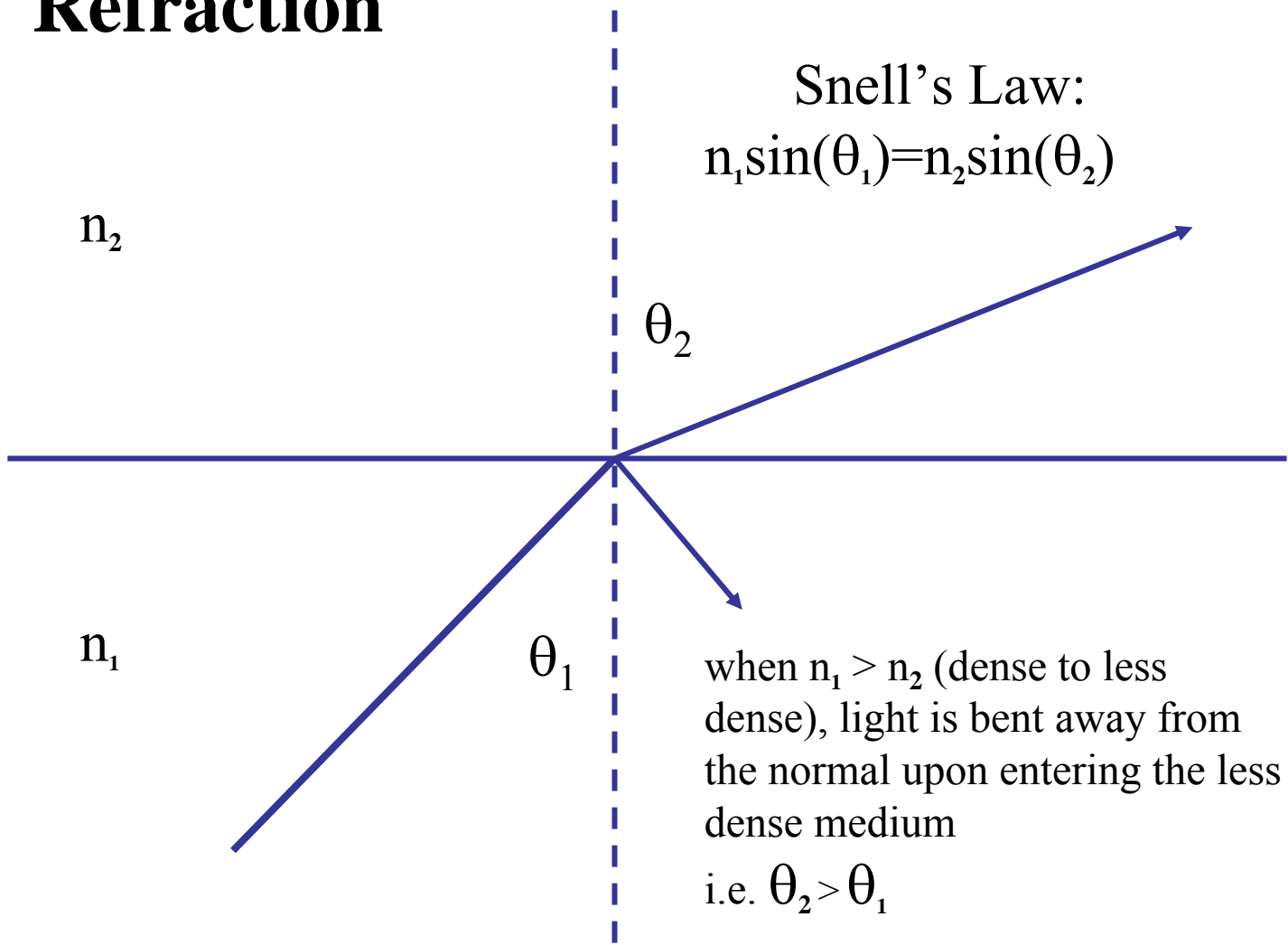


TIRF: total internal reflectance fluorescence microscopy

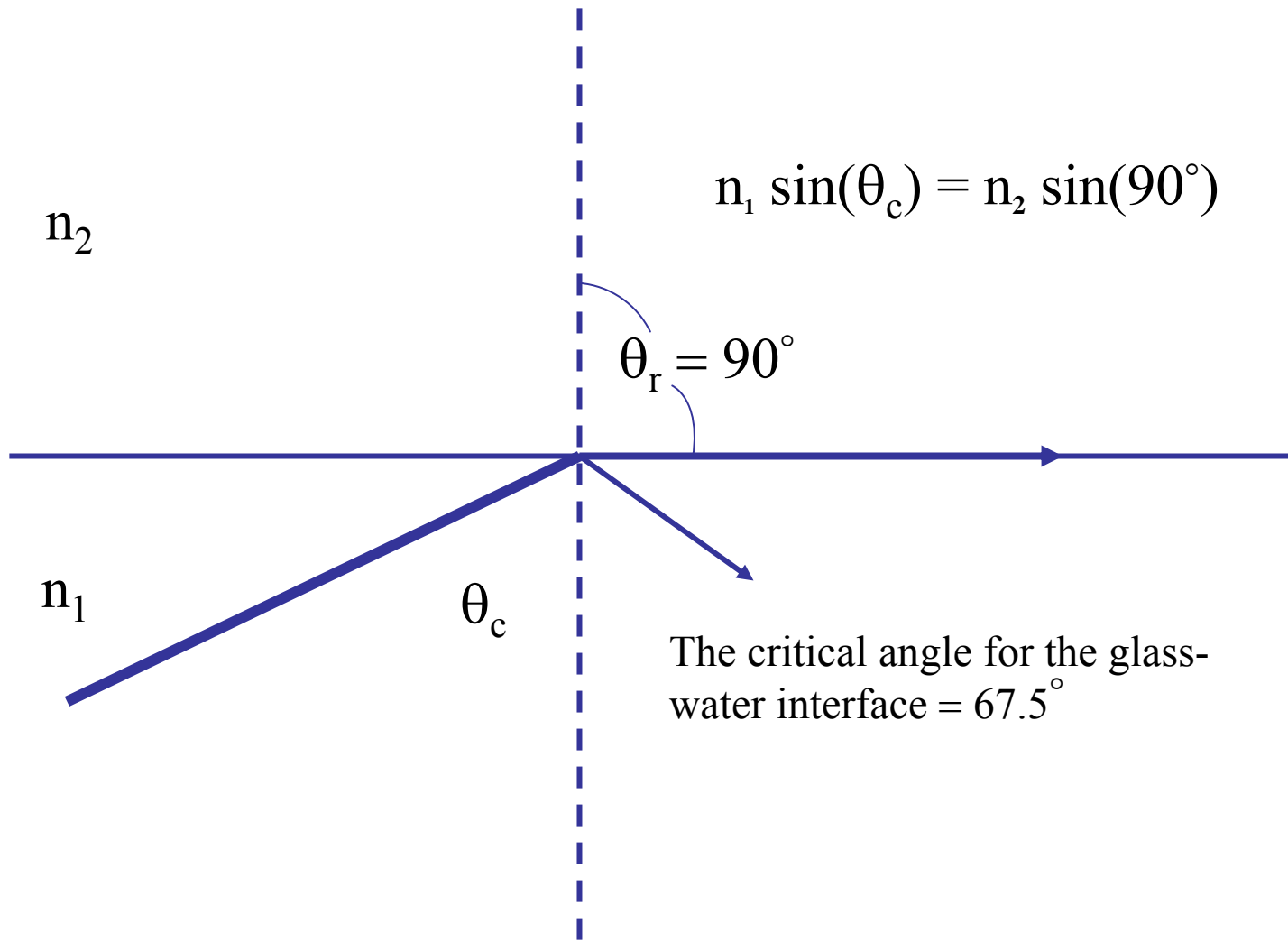
TIRF (Axelrod and coworkers)



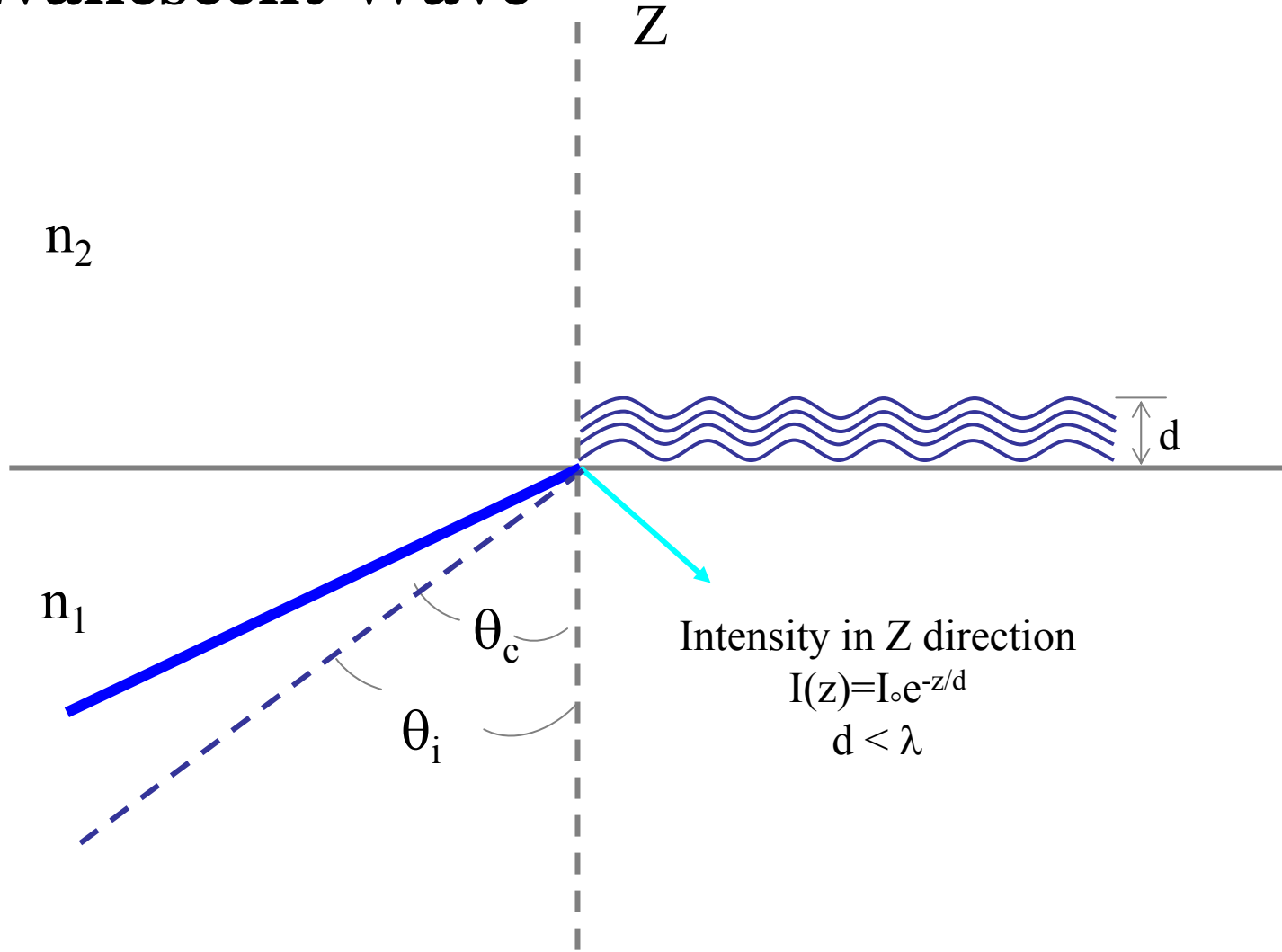
Refraction



Total internal reflection and the critical angle



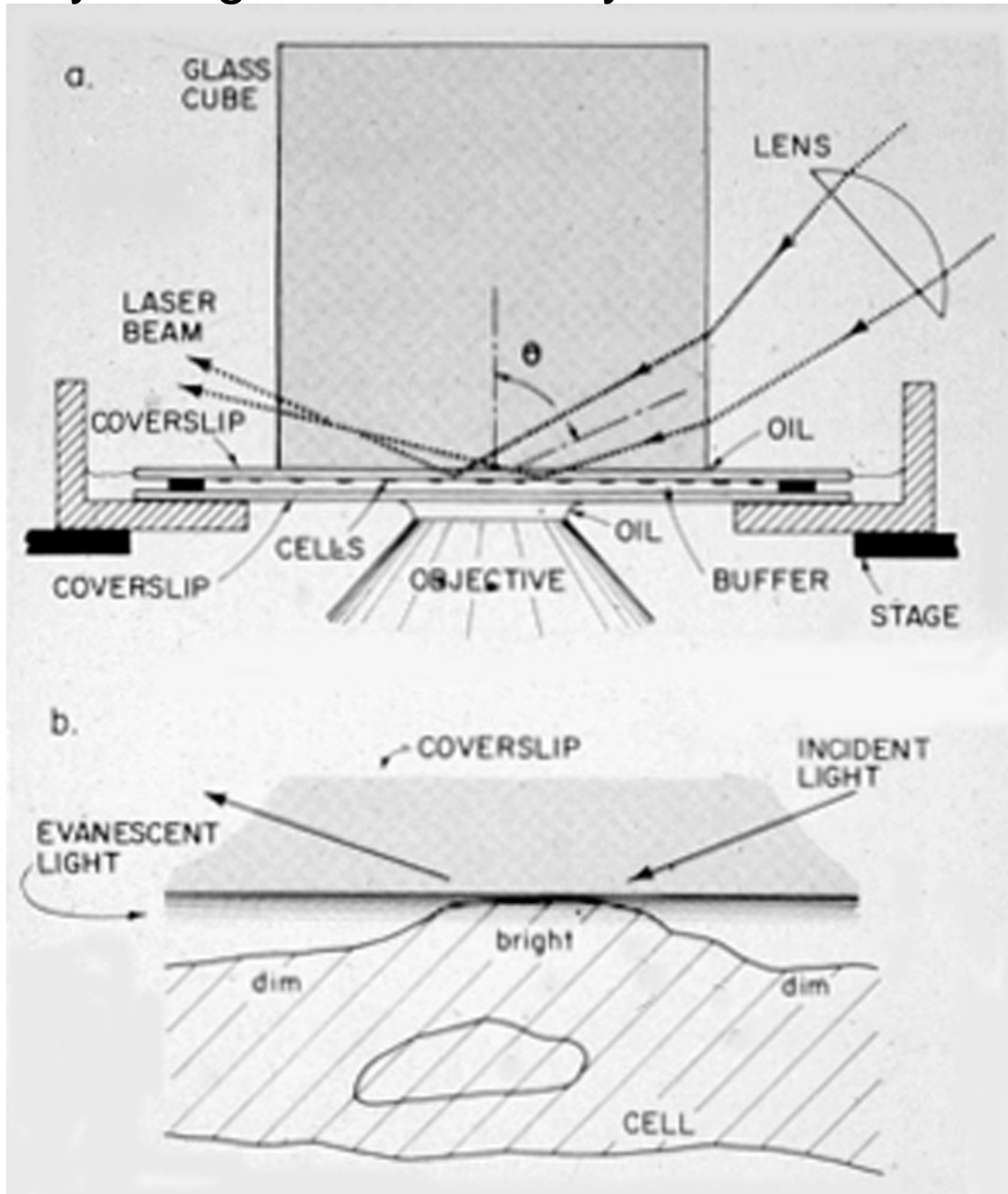
Evanescent Wave



Depth of evanescent wave (d) depends on angle of incidence, θ_i : it is largest close to the critical angle, θ_c

$$d = \frac{1}{\sqrt{\frac{\sin^2 \theta_i}{\sin^2 \theta_c} - 1}} \times \frac{\lambda}{4\pi n}$$

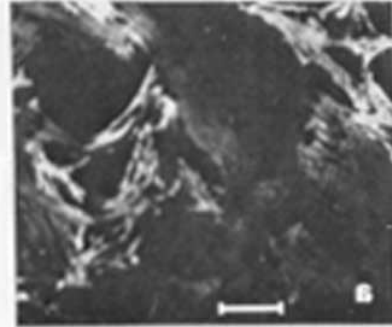
Early design circa 1980 by Dan Axelrod



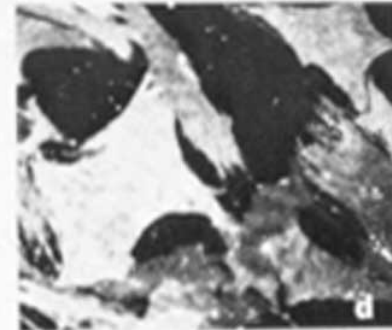
74.3 deg;
d=105nm



72.5 deg; d=120nm



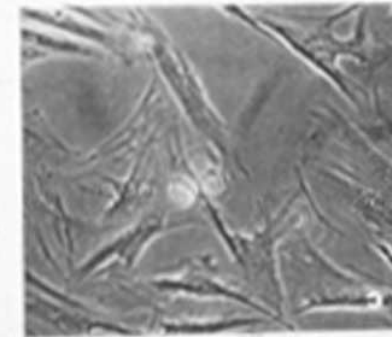
epi



74.3 deg; d=405nm



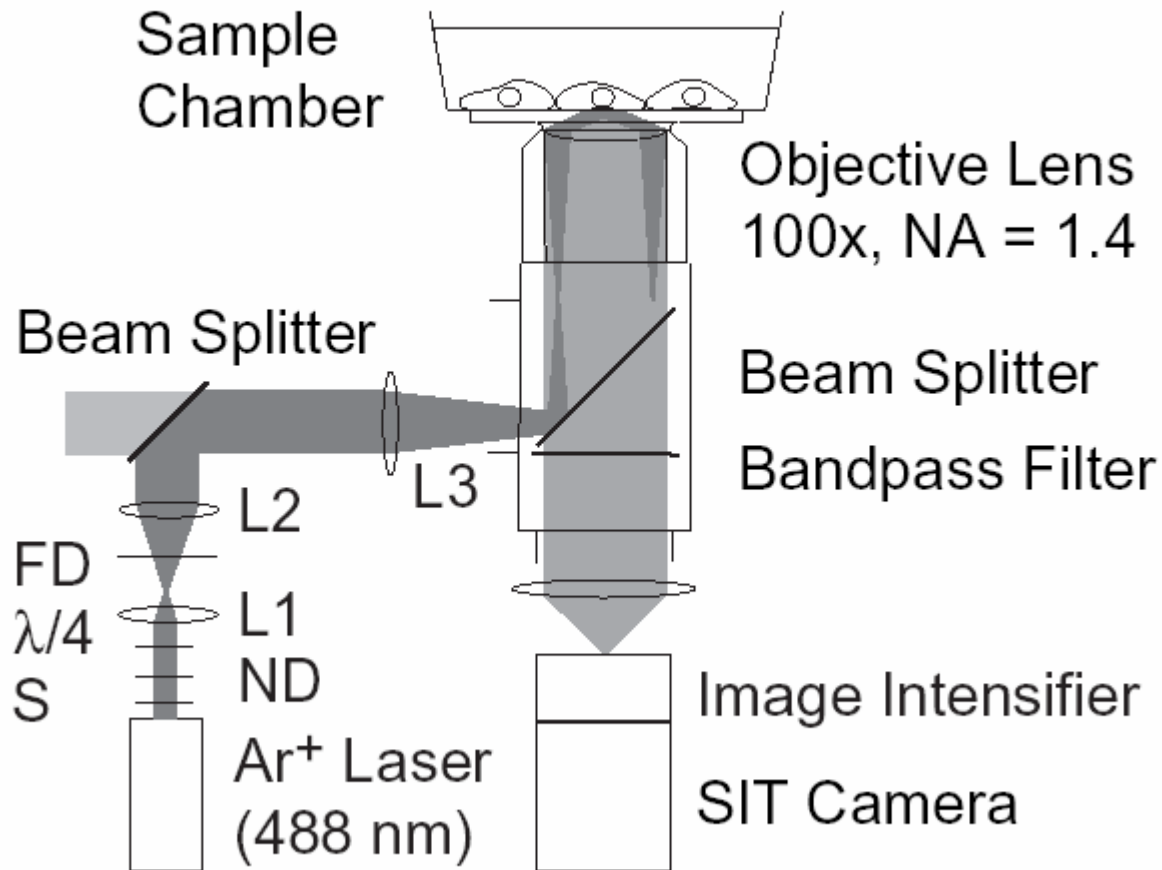
phase



[Faint, illegible text from the original document, likely bleed-through from the reverse side.]

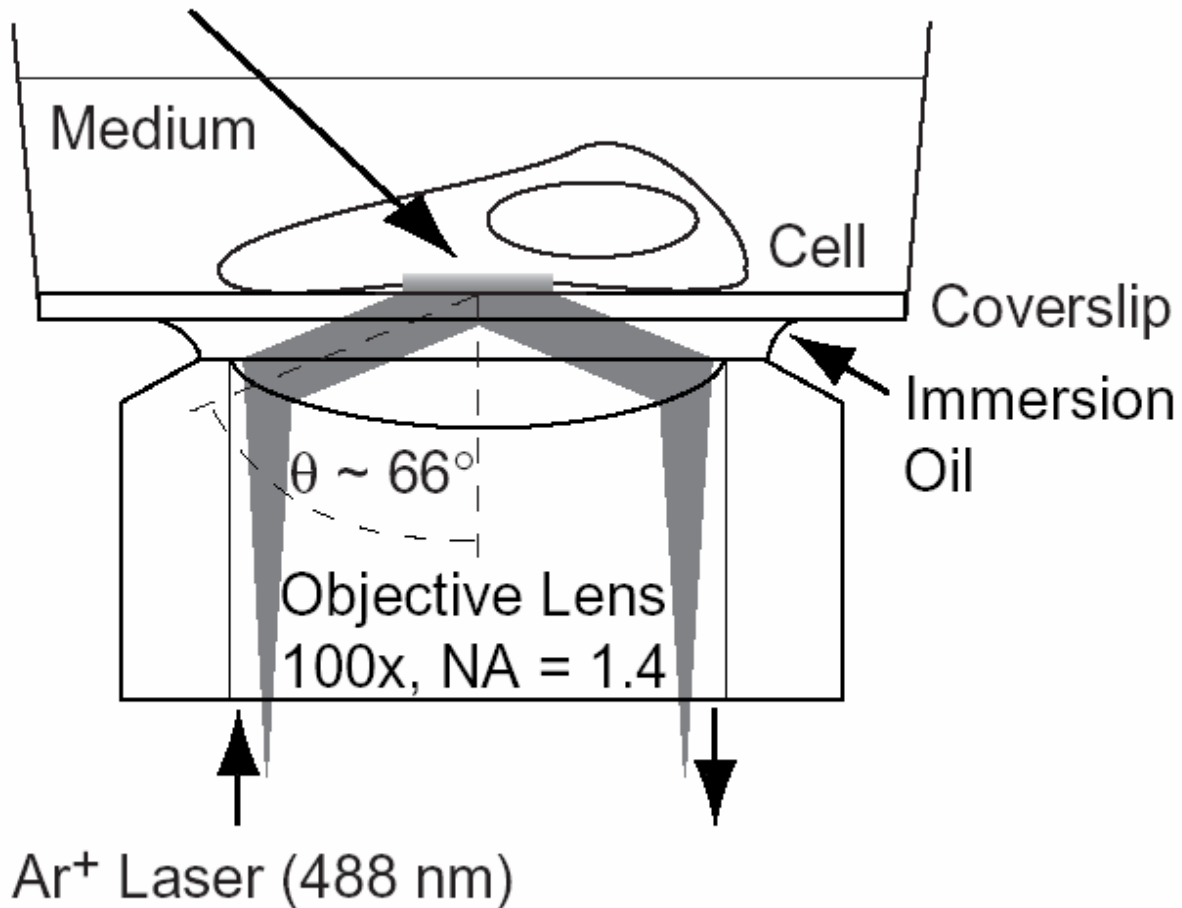
TIRF excitation using the objective

A



B

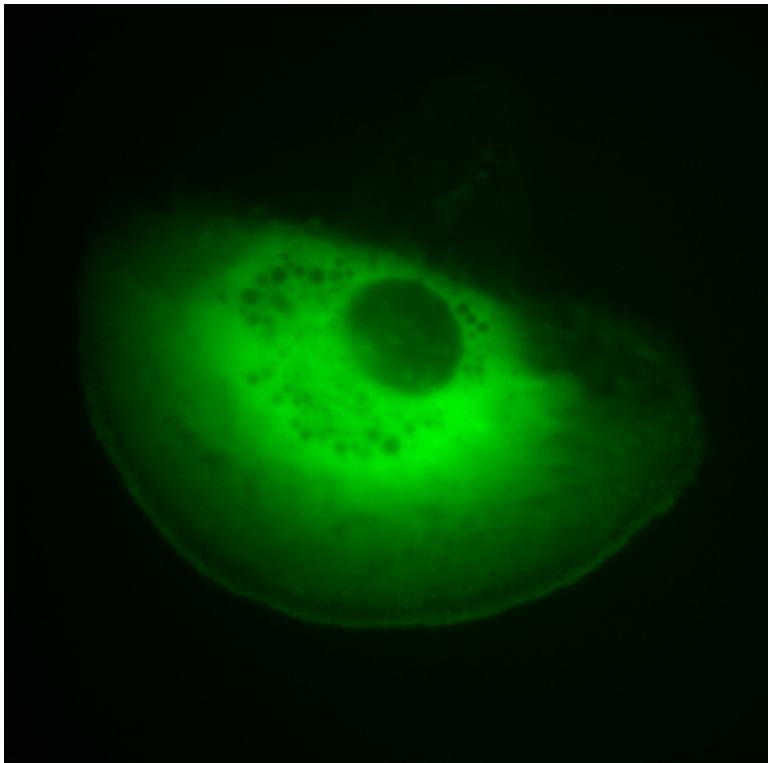
Evanescent Field ($d_{1/e} \sim 100$ nm, $\phi \sim 13$ μ m)



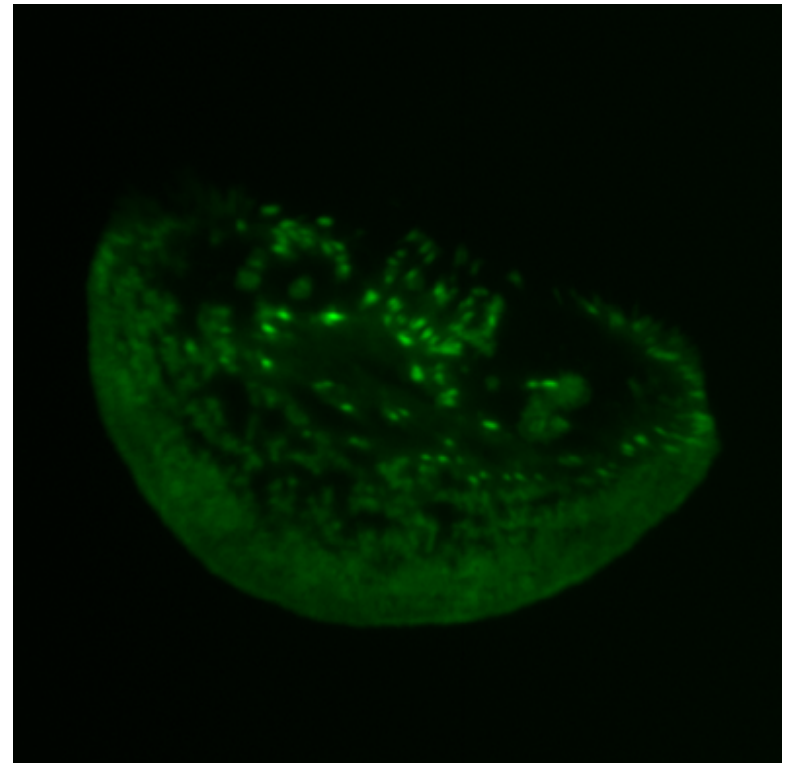
Iino and Kusumi, J. Fluorescence (2001)

Expression of EGFP-paxillin Mutant in MDA-MB-231
Human Breast Cancer Cells
Olympus 60x, 1.45 NA

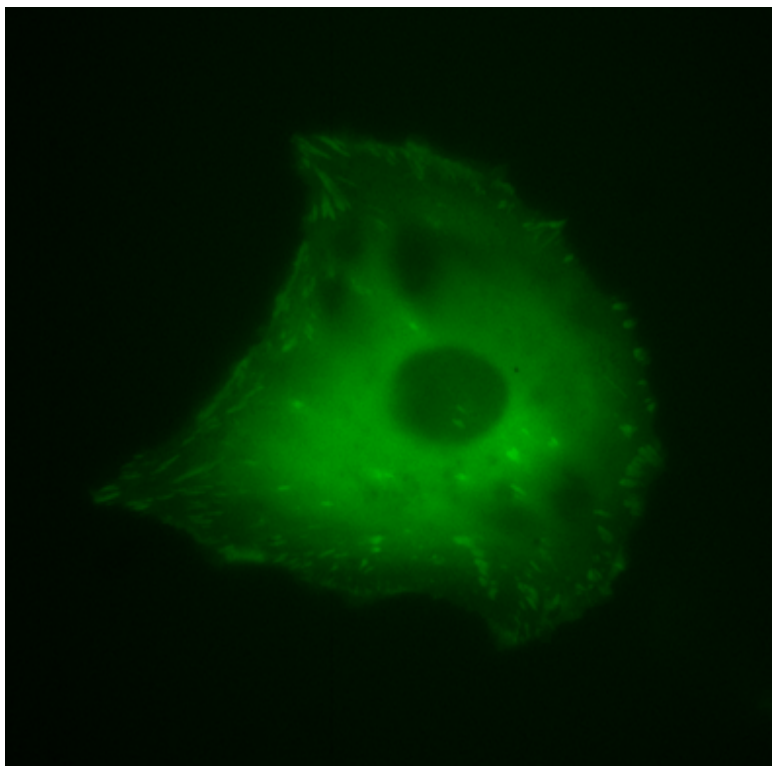
EPI
EGFP



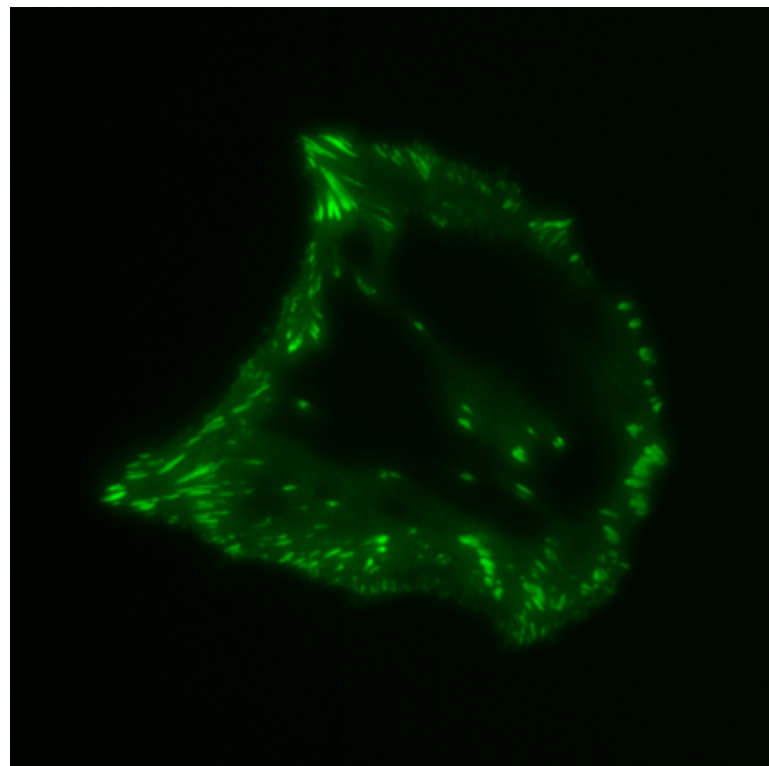
TIRF



EPI



TIRF



Single molecule studies using TIRF

Yanagida et al Nature 374: 555
(1995)

